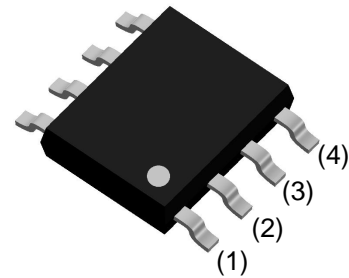
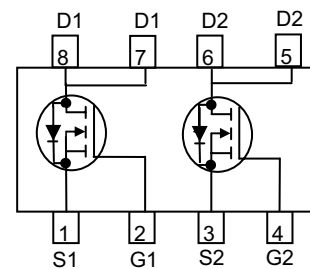


WPMD4953
Dual P-Channel, -30V, -4.9A, Power MOSFET
[Http://www.willsemi.com](http://www.willsemi.com)

V_{DS} (V)	$R_{ds(on)}$ (Ω)
-30	0.049@ $V_{GS}=-10V$
	0.070@ $V_{GS}=-4.5V$


SOP-8L

Pin configuration (Top view)


WLSI = Company
 4953 = Device Code
 PD = Special Code
 Y = Year
 W = Week(A~z)

Marking
Descriptions

The WPMD4953 is the Dual P-Channel enhancement MOS Field Effect Transistor. Uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. This device is suitable for use in DC-DC conversion, power switch and charging circuit. Standard Product WPMD4953 is Pb-free and Halogen-free.

Features

- Super high density cell design for extremely low $R_{DS(ON)}$
- Exceptional on-resistance and maximum DC current capability
- SOP-8L package design

Applications

- Power Management in Note book
- Portable Equipment
- Battery Powered System
- DC/DC Converter
- Load Switch
- DSC
- LCD Display inverter

Order information

Device	Package	Shipping
WPMD4953-8/TR	SOP-8L	4000/Reel&Tape

Absolute Maximum ratings

Parameter		Symbol	10 S	Steady State	Unit
Drain-Source Voltage		V_{DS}	-30		V
Gate-Source Voltage		V_{GS}	± 20		
Continuous Drain Current ^a	$T_A=25^\circ\text{C}$	I_D	-4.9	-3.8	A
	$T_A=70^\circ\text{C}$		-3.9	-3.0	
Maximum Power Dissipation ^a	$T_A=25^\circ\text{C}$	P_D	1.9	1.1	W
	$T_A=70^\circ\text{C}$		1.2	0.7	
Continuous Drain Current ^b	$T_A=25^\circ\text{C}$	I_D	-4.5	-3.6	A
	$T_A=70^\circ\text{C}$		-3.6	-2.9	
Maximum Power Dissipation ^b	$T_A=25^\circ\text{C}$	P_D	1.6	1.0	W
	$T_A=70^\circ\text{C}$		1.0	0.6	
Pulsed Drain Current ^c		I_{DM}	-25		A
Operating Junction Temperature		T_J	150		$^\circ\text{C}$
Lead Temperature		T_L	260		$^\circ\text{C}$
Storage Temperature Range		T_{stg}	-55 to 150		$^\circ\text{C}$

Thermal resistance ratings

Single Operation					
Parameter		Symbol	Typical	Maximum	Unit
Junction-to-Ambient Thermal Resistance ^a	$t \leq 10 \text{ s}$	$R_{\theta JA}$	56	65	$^\circ\text{C}/\text{W}$
	Steady State		87	105	
Junction-to-Ambient Thermal Resistance ^b	$t \leq 10 \text{ s}$	$R_{\theta JA}$	64	76	
	Steady State		96	115	
Junction-to-Case Thermal Resistance		$R_{\theta JC}$	32	40	
Dual Operation					
Junction-to-Ambient Thermal Resistance ^a	$t \leq 10 \text{ s}$	$R_{\theta JA}$	61	70	
	Steady State		92	112	
Junction-to-Ambient Thermal Resistance ^b	$t \leq 10 \text{ s}$	$R_{\theta JA}$	69	82	
	Steady State		102	120	
Junction-to-Case Thermal Resistance		$R_{\theta JC}$	36	45	

a Surface mounted on FR4 Board using 1 square inch pad size, 1oz copper

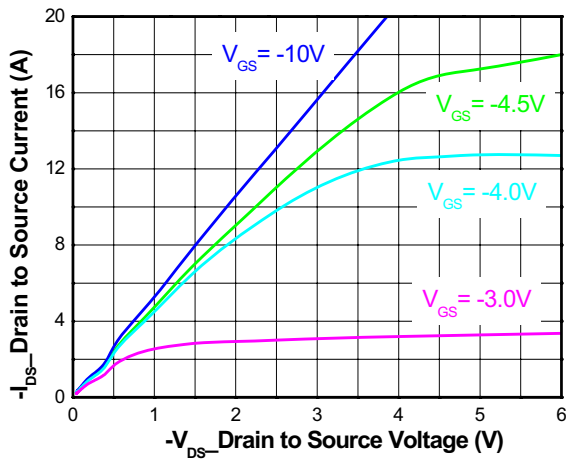
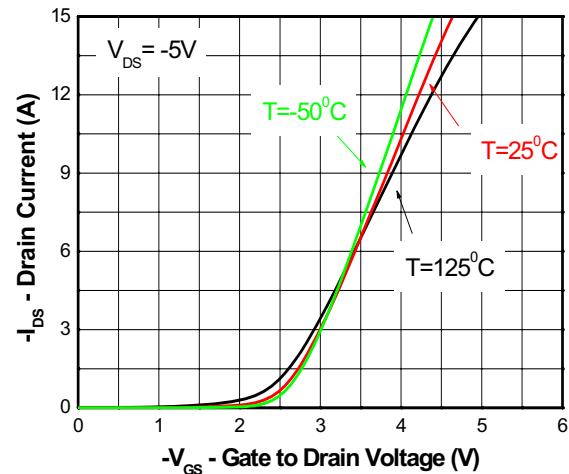
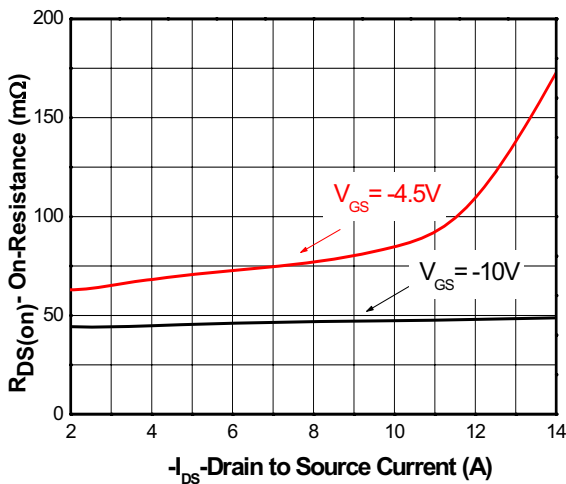
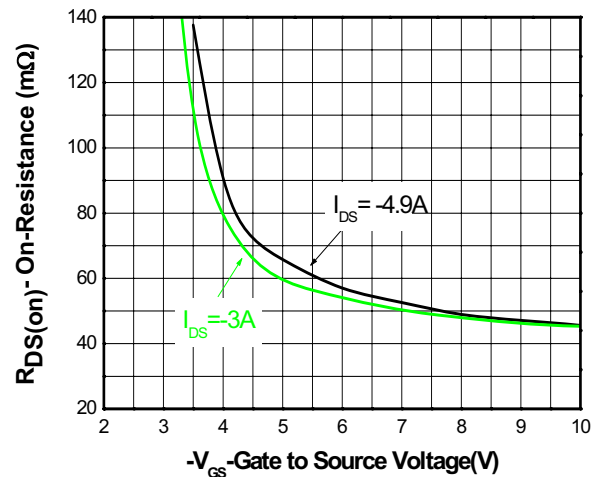
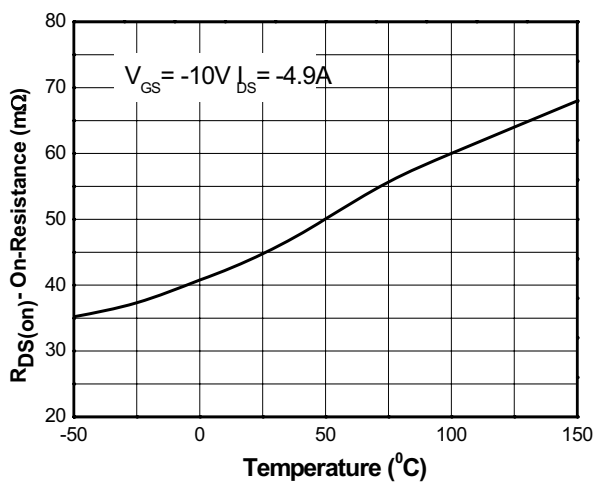
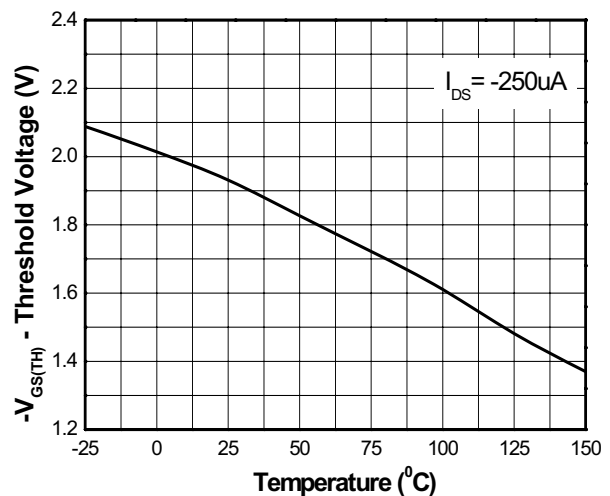
b Surface mounted on FR4 board using minimum pad size, 1oz copper

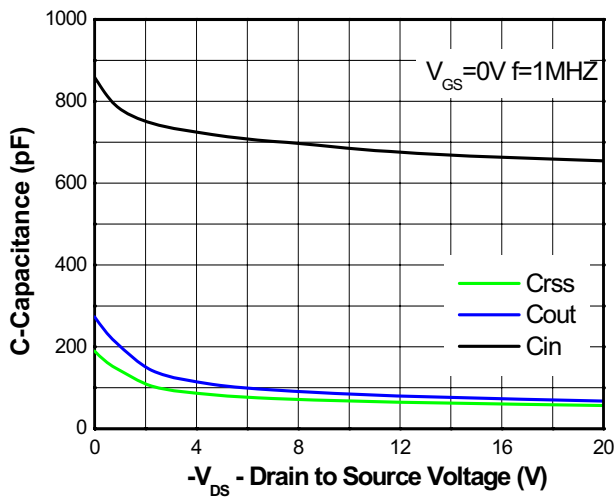
c Repetitive rating, pulse width limited by junction temperature, $t_p=10\mu\text{s}$, Duty Cycle=1%

d Repetitive rating, pulse width limited by junction temperature $T_J=150^\circ\text{C}$.

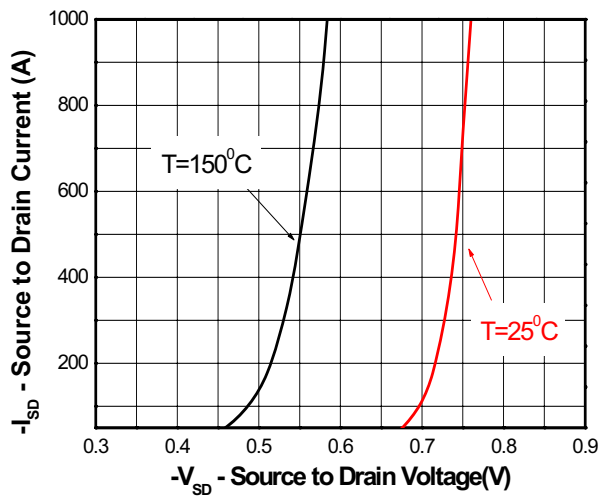
Electronics Characteristics (Ta=25°C, unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage	BV_{DSS}	$V_{GS} = 0\text{ V}, I_D = -250\mu\text{A}$	-30			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -24\text{ V}, V_{GS} = 0\text{ V}$			-1	μA
Gate-to-source Leakage Current	I_{GSS}	$V_{DS} = 0\text{ V}, V_{GS} = \pm 20\text{ V}$			± 100	nA
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = -250\mu\text{A}$	-1.5	-1.9	-2.5	V
Drain-to-source On-resistance	$R_{DS(on)}$	$V_{GS} = -10\text{ V}, I_D = -4.9\text{ A}$		49	60	m Ω
		$V_{GS} = -4.5\text{ V}, I_D = -4.0\text{ A}$		70	90	
Forward Transconductance	g_{FS}	$V_{DS} = -15\text{ V}, I_D = -3.0\text{ A}$		5.0		S
CHARGES, CAPACITANCES AND GATE RESISTANCE						
Input Capacitance	C_{ISS}	$V_{GS} = 0\text{ V}, f = 1\text{ MHz}, V_{DS} = -15\text{ V}$		670		pF
Output Capacitance	C_{OSS}			75		
Reverse Transfer Capacitance	C_{RSS}			62		
Total Gate Charge	$Q_{G(TOT)}$	$V_{GS} = -10\text{ V}, V_{DS} = -15\text{ V}, I_D = -4.9\text{ A}$		14.0		nC
Threshold Gate Charge	$Q_{G(TH)}$			1.31		
Gate-to-Source Charge	Q_{GS}			1.80		
Gate-to-Drain Charge	Q_{GD}			1.60		
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	$t_d(ON)$	$V_{GS} = -10\text{ V}, V_{DS} = -15\text{ V}, R_L = 5.0\ \Omega, R_G = 15\ \Omega$		6.8		ns
Rise Time	t_r			3.2		
Turn-Off Delay Time	$t_d(OFF)$			25.2		
Fall Time	t_f			4.4		
BODY DIODE CHARACTERISTICS						
Forward Voltage	V_{SD}	$V_{GS} = 0\text{ V}, I_S = -1.0\text{ A}$	-0.55	-0.78	-1.5	V

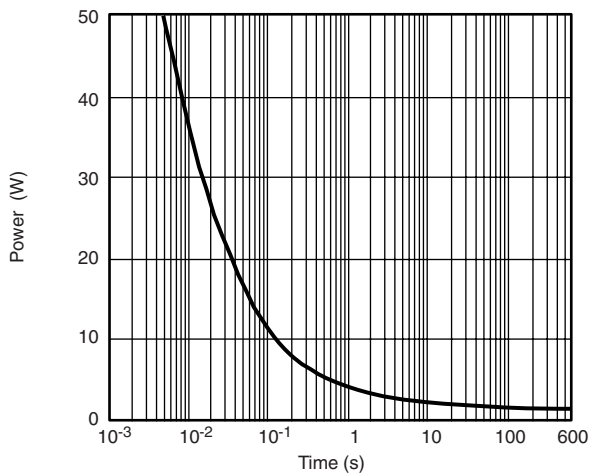
Typical Characteristics (Ta=25°C, unless otherwise noted)

Output characteristics

Transfer characteristics

On-Resistance vs. Drain current

On-Resistance vs. Gate-to-Source voltage

On-Resistance vs. Junction temperature

Threshold voltage vs. Temperature



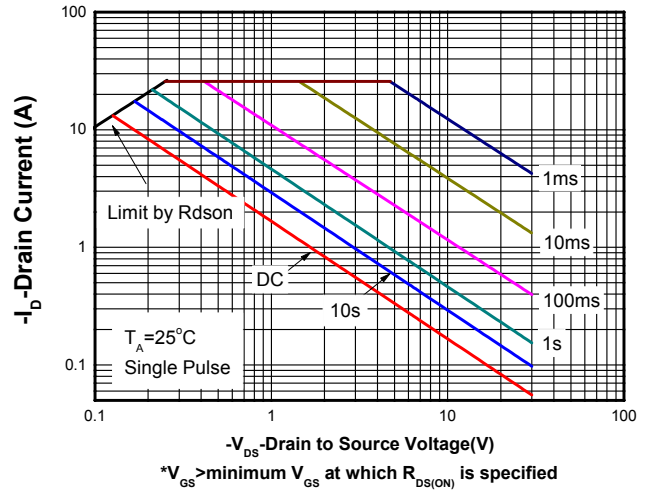
Capacitance



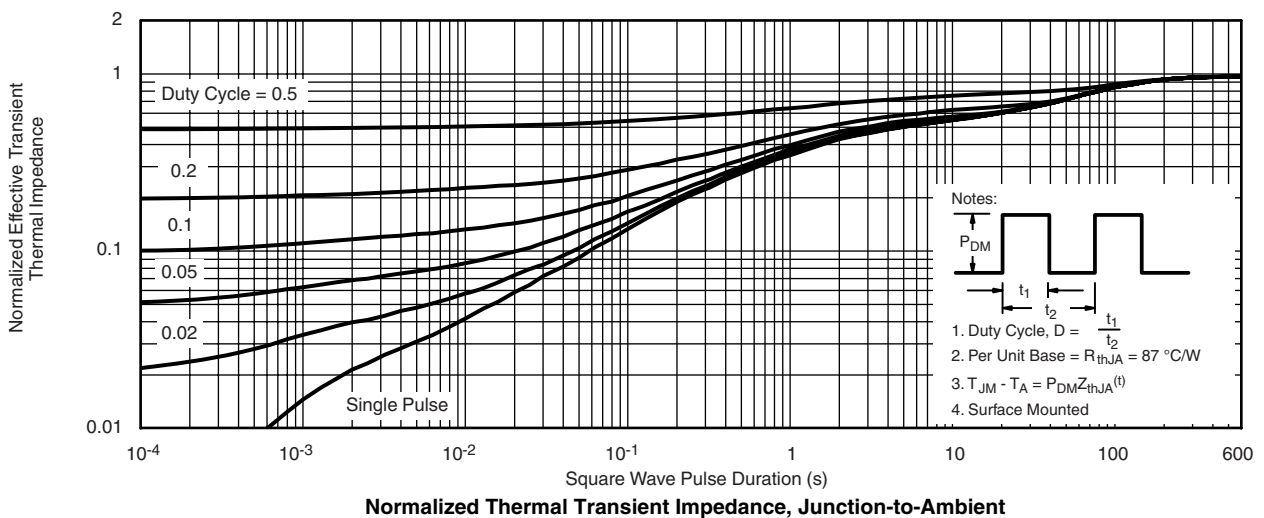
Body diode forward voltage

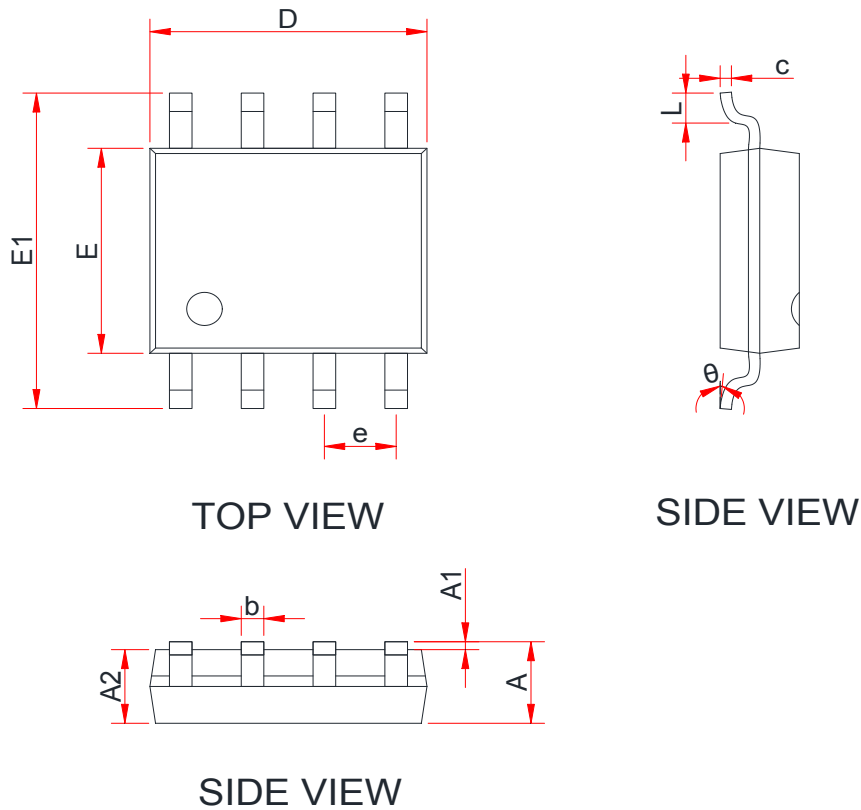


Single pulse power

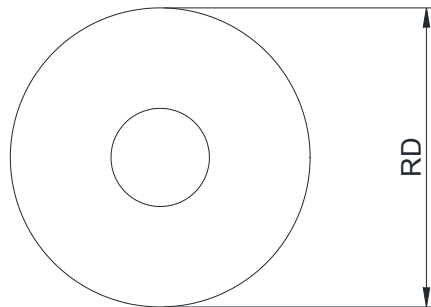
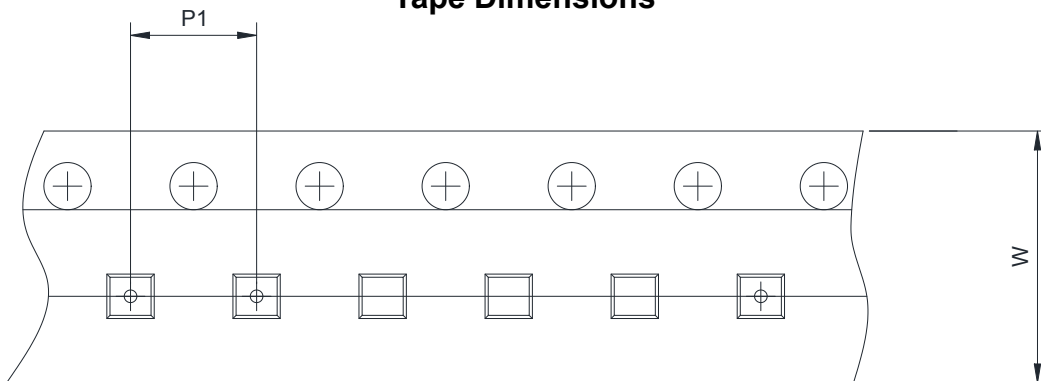
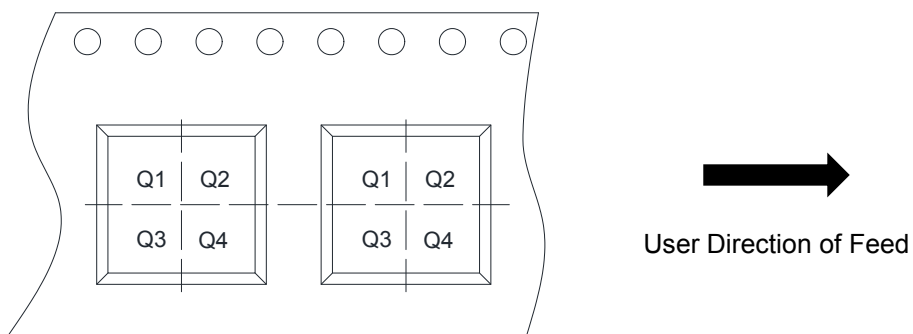


Safe operating power



Package outline dimensions
SOP-8L


Symbol	Dimensions In Millimeters (mm)		
	Min.	Typ.	Max.
A	1.35	1.55	1.75
A1	0.05	0.15	0.25
A2	1.25	1.40	1.65
b	0.33	-	0.51
c	0.15	-	0.26
D	4.70	4.90	5.10
E	3.70	3.90	4.10
E1	5.80	6.00	6.20
e	1.27BSC		
L	0.40	-	1.27
θ	0°	-	8°

TAPE AND REEL INFORMATION
Reel Dimensions

Tape Dimensions

Quadrant Assignments For PIN1 Orientation In Tape


RD	Reel Dimension	<input type="checkbox"/> 7inch	<input checked="" type="checkbox"/> 13inch		
W	Overall width of the carrier tape	<input type="checkbox"/> 8mm	<input checked="" type="checkbox"/> 12mm		
P1	Pitch between successive cavity centers	<input type="checkbox"/> 2mm	<input type="checkbox"/> 4mm	<input checked="" type="checkbox"/> 8mm	
Pin1	Pin1 Quadrant	<input checked="" type="checkbox"/> Q1	<input type="checkbox"/> Q2	<input type="checkbox"/> Q3	<input type="checkbox"/> Q4